## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10751436	LEE ET AL.	

 Examiner
 Art Unit

 CongVan Tran
 2617

SEARCHED						
Class	Subclass	Date	Examiner			
370	401, 328, 351	3/12/08	CT			
455	433	3/12/08	CT			
370	352-356	10/10/08	CT			

SEARCH NOTES			
Search Notes	Date	Examiner	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

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